

<b>Notice of References Cited</b>	Application/Control No. 10/574,365		Applicant(s)/Patent Under Reexamination PHAN LE, KIM	
	Examiner ALEXANDER G. SOFOCLEOUS		Art Unit 2824	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,914,805	07-2005	Witcraft et al.	365/158
*	B	US-6,873,055	03-2005	Bangert, Joachim	257/775
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	WO 02/41367 Jones et al. "Self-Aligned Magnetic Clad Write Line and Method Thereof." published May 22, 2002
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.